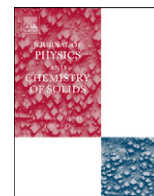




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journal homepage: [www.elsevier.com/locate/jpcs](http://www.elsevier.com/locate/jpcs)Phase evolution and microwave dielectric properties of  $\text{Bi}_3\text{SbO}_7$  ceramicLi-Xia Pang<sup>a,\*</sup>, Di Zhou<sup>b</sup>, Hong Wang<sup>b</sup>, Ying Wu<sup>b</sup>, Jing Guo<sup>b</sup>, Yue-Hua Chen<sup>b</sup><sup>a</sup> Laboratory of Thin Film Techniques and Optical Test, Xi'an Technological University, No. 4, Jin Hua North Road, Xi'an 710032, China<sup>b</sup> Electronic Materials Research Laboratory, Key Laboratory of the Ministry of Education, Xi'an Jiaotong University, Xi'an 710049, China

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## ABSTRACT

The  $\text{Bi}_3\text{SbO}_7$  ceramic was prepared by the solid state reaction method and its phase evolution at different temperatures was studied. Low temperature phase  $\alpha$ - $\text{Bi}_3\text{SbO}_7$  was formed at about 890 °C and it started to transform to high temperature phase  $\beta$ - $\text{Bi}_3\text{SbO}_7$  at about 960 °C. Microwave dielectric constants of  $\alpha$ - $\text{Bi}_3\text{SbO}_7$  ceramic and  $\beta$ - $\text{Bi}_3\text{SbO}_7$  ceramic were 43.2 and 37.6,  $Qf$  value were 2080 and 5080 GHz, respectively. TCF of  $\alpha$ - $\text{Bi}_3\text{SbO}_7$  ceramic was near zero and TCF of  $\beta$ - $\text{Bi}_3\text{SbO}_7$  ceramic was about  $-120$  ppm/°C. The  $\text{Bi}_3\text{SbO}_7$  ceramic is a promising candidate for low temperature co-fired ceramic (LTCC) technology due to its large dielectric constant, low dielectric loss at microwave region, low sintering temperature and simple composition.

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## 1. Introduction

The development of multilayer microwave chips and devices demands dielectric materials with large dielectric constant ( $\epsilon_r$ ), high quality value ( $Q$ ), near zero temperature coefficient of resonant frequency (TCF) and sintering temperatures ( $T_s$ ) lower than the melting point of common metal electrode materials, such as Ag, Cu, Al, etc., in order to use low temperature co-fired ceramic (LTCC) technology to produce chips with internal electrodes. Most dielectric ceramics with good microwave dielectric properties have relative high sintering temperature. Addition of sintering aids with low melting temperatures is an effective method to lower the firing temperature of ceramics. Recently many new simple binary or ternary compounds with low densification temperature have been found to possess good microwave dielectric properties and they have attracted more and more attention [1–4].

Bismuth-based dielectric ceramics are well-known as low-fired materials and have been investigated for the application as multilayer capacitors [5–9]. Besides  $\text{Bi}_2\text{O}_3$ – $\text{Nb}_2\text{O}_5$  binary system and  $\text{Bi}_2\text{O}_3$ – $(\text{Zn,Ca})\text{O}$ – $\text{Nb}_2\text{O}_5$  ternary system, monoclinic  $\text{BiSbO}_4$  in  $\text{Bi}_2\text{O}_3$ – $\text{Sb}_2\text{O}_3$  system was also found to be a promising candidate for LTCC and some modifications of  $\text{BiSbO}_4$  ceramic have been done [10,11] and being done in our recent work. In fact as early as about twenty years ago, many works have investigated the solid state reactions and phase diagram of the binary system of  $\text{Bi}_2\text{O}_3$ – $\text{Sb}_2\text{O}_3$  [12–18]. In this binary system, some original

stoichiometric compounds such as  $\text{BiSbO}_4$ ,  $(\text{Bi,Sb})\text{SbO}_4$ ,  $\text{Bi}_5\text{Sb}_2\text{O}_{12.5}$ ,  $\text{Bi}_3\text{SbO}_7$  and  $\text{Sb}_3\text{BiO}_7$  are known to occur, in which  $\text{BiSbO}_4$  and  $\text{Bi}_3\text{SbO}_7$  compositions have been studied more broadly than others for their potential application in photocatalyst and dielectric resonator fields [10,11,19–22].  $\text{BiSbO}_4$  is known to crystallize in monoclinic symmetry and  $\text{Bi}_3\text{SbO}_7$  exists in two polymorphs: the low-temperature polymorph ( $\alpha$ ) has a triclinic structure, and the high-temperature one ( $\beta$ ) has an orthorhombic structure. According to Tairi et al. [17] and Manier et al. [21] the polymorphic transformation occurs at about 1030 °C. As shown by X-ray photoelectron spectroscopy (XPS) [20], the antimony in  $\text{Bi}_3\text{SbO}_7$  is in its highest oxidation state,  $5^+$ . The XPS data reported by Schuh et al. [23] and the isomorphism of  $\text{BiSbO}_4$  and  $\beta$ - $\text{Sb}_2\text{O}_4$ , a mixed oxide of  $\text{Sb}^{3+}$  and  $\text{Sb}^{5+}$  [24–26], give grounds to expect that the antimony in  $\text{BiSbO}_4$  is also presented in the form of  $\text{Sb}^{5+}$ .  $\text{Bi}_3\text{SbO}_7$  melts congruently at a temperature close to about 1120 °C. Its high temperature  $\beta$  phase can be stabilized in the metastable state by quenching. Manier et al. [21] studied the microwave dielectric properties of  $\text{Bi}_3\text{SbO}_7$  ceramics (relative density between 93.7% and 94.8%) prepared by solid state reaction method and co-precipitate method in detail. Their results showed that the low-temperature polymorph  $\alpha$ - $\text{Bi}_3\text{SbO}_7$  ceramic was a good candidate for dielectric resonator having a dielectric constant between 34.6 and 42.1 and microwave dielectric losses lied between  $5 \times 10^{-4}$  and  $7 \times 10^{-4}$  while temperature coefficient of resonant frequency shifting between  $-31.3$  and  $-88$  ppm/°C (at resonant frequency about 6.6–7.3 GHz). In the present study, phase evolution of  $\text{Bi}_3\text{SbO}_7$  composition versus sintering temperature under air atmosphere and the relationship between phase and microwave dielectric properties have been studied.

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## 2. Experimental procedure

Proportionate amounts of reagent-grade starting materials of  $\text{Bi}_2\text{O}_3$  (> 99%, Cheng Du of China) and  $\text{Sb}_2\text{O}_3$  (three kinds of starting materials were used to repeat all the experimental results, > 99%, Guo-Yao Co. Ltd., Shanghai, China; > 99%, Xi'an Chemical Reagent, Xi'an, China; > 99%, Fuchen Chemical Reagents, Tianjin, China) were prepared according to the composition  $\text{Bi}_3\text{SbO}_7$ . Powders were mixed and milled for 4 h using a planetary mill (Nanjing Machine Factory, Nanjing, China) by setting the running speed at 150 rpm with the zirconia balls (2 mm in diameter) as milling media. To investigate the phase evolution, some of the mixed powders were calcined at different temperatures in the range from 500 to 1070 °C for 2 h, respectively. In order to investigate the microwave dielectric properties of  $\text{Bi}_3\text{SbO}_7$  ceramics, other powders were calcined at 600 and 700 °C for 4 h, respectively, first to fulfill thorough oxidation from  $\text{Sb}_2\text{O}_3$  to  $\text{Sb}_2\text{O}_5$ . After being crushed and re-milled for 5 h using  $\text{ZrO}_2$  balls and deionized water, powders were pressed into cylinders (10 mm in diameter and 5 mm in height) in a steel die under uniaxial pressure of 20 kN/cm<sup>2</sup> with PVA binder addition. Then samples were sintered from 860 to 1070 °C for 2 h and naturally cooled down to room temperature under air atmosphere (the natural cooling rate of the furnace used here was about 10 °C/min when temperature is above 800 °C, the cooling rate becomes very slow about lower than 5 °C/min).

The crystalline structures of samples (ground powders of the sintered ceramics) were investigated using X-ray diffraction with  $\text{Cu K}\alpha$  radiation (Rigaku D/MAX-2400 X-ray diffractometry, Tokyo, Japan) and using ground powders. The apparent densities of sintered ceramics were measured by Archimedes' method. Dielectric behaviors at microwave frequency were measured by the  $\text{TE}_{018}$  shielded cavity method with a network analyzer (8720ES, Agilent, Palo Alto, U.S.A.) and a temperature chamber (DELTA 9023, Delta Design, Poway, U.S.A.). The temperature coefficient of resonant frequency (TCF) was calculated by the following formula:

$$\text{TCF} = \frac{f_{85} - f_{25}}{f_{25}(85 - 25)} \times 10^6 (\text{ppm}/^\circ\text{C}) \quad (1)$$

where  $f_{85}$  and  $f_{25}$  were the  $\text{TE}_{018}$  resonant frequencies at 85 and 25 °C, respectively.

## 3. Results and discussion

Fig. 1 shows the XRD patterns of  $3\text{Bi}_2\text{O}_3\text{-Sb}_2\text{O}_3$  samples calcined and sintered at different temperatures for 2 h. After calcined at 500 °C for 2 h,  $\text{Sb}_2\text{O}_3$  was first oxygenized to  $\text{Sb}_2\text{O}_4$ . Then a new single phase seemed to be formed at 600 °C. Peaks of this phase were similar to that of cubic  $\text{Bi}_3\text{NbO}_7$  and  $\text{Bi}_3\text{TaO}_7$  [27,28]. It was not stable and easy to transform to other phases when temperature increased. Low temperature phase of  $\text{Bi}_3\text{SbO}_7$  was formed at about 890 °C and strong peaks could be observed in well crystalloid ceramic sintered at 920 °C as shown in Fig. 1. When sintering temperature was above 960 °C, low temperature phase  $\alpha\text{-Bi}_3\text{SbO}_7$  began to transform to high temperature phase  $\beta\text{-Bi}_3\text{SbO}_7$  gradually. At around 1020 °C, pure high temperature phase  $\beta\text{-Bi}_3\text{SbO}_7$  was obtained. This result was similar to that reported by Tairi et al. [17], Manier et al. [21] and Dinnebier et al. [24]. The clear course of phase transformation in  $\text{Bi}_3\text{SbO}_7$  ceramic were first shown in this work. Different starting materials had a little influence on the phase transformation temperature but the trend was always the same.

Apparent densities of  $\text{Bi}_3\text{SbO}_7$  ceramics as a function of sintering temperature are shown in Fig. 2. As sintering temperature increased from 900 to about 980 °C, apparent density increased from about 8.37 to 8.65 g/cm<sup>3</sup> because of both

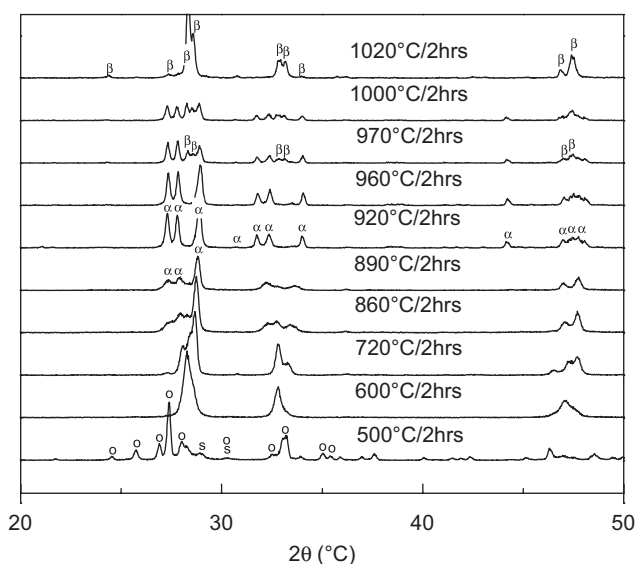


Fig. 1. XRD patterns of  $3\text{Bi}_2\text{O}_3\text{-Sb}_2\text{O}_3$  samples calcined and sintered at different temperatures for 2 h ( $\alpha\text{-Bi}_3\text{SbO}_7$  (PDF: 45-0925),  $\beta\text{-Bi}_3\text{SbO}_7$  (PDF: 39-0979),  $o\text{-Bi}_2\text{O}_3$ ,  $s\text{-Sb}_2\text{O}_4$ ).

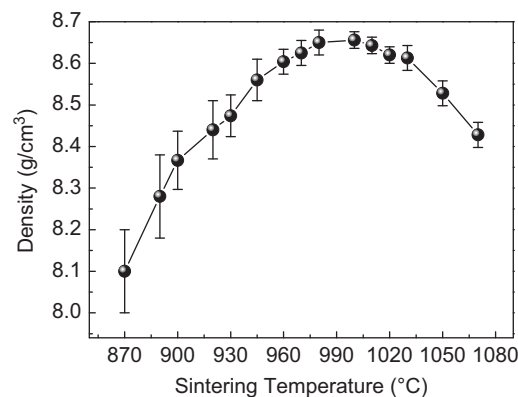


Fig. 2. Apparent density of  $\text{Bi}_3\text{SbO}_7$  ceramics as a function of sintering temperature.

pores being eliminated and phase transformation from  $\alpha\text{-Bi}_3\text{SbO}_7$  to  $\beta\text{-Bi}_3\text{SbO}_7$  gradually. Theoretical density of pure  $\alpha\text{-Bi}_3\text{SbO}_7$  and  $\beta\text{-Bi}_3\text{SbO}_7$  are 8.738 and 8.958 g/cm<sup>3</sup>, respectively [17]. Measured density of  $\alpha\text{-Bi}_3\text{SbO}_7$  ceramic sintered at 960 °C was about 8.60 g/cm<sup>3</sup>, which is equivalent to a relative density of about 98% of the theoretical density. Measured density of  $\beta\text{-Bi}_3\text{SbO}_7$  ceramic sintered at 1020 °C was about 8.61 g/cm<sup>3</sup> and its relative density of about 96%. When sintering temperature increased above 1000 °C, bismuth volatilization should be accounted to the decrease of density. It must be pointed out that different starting materials would affect the Bi-loss very much and serious volatilization of bismuth at high temperature would cause the nonstoichiometry in samples. Microstructures of  $\text{Bi}_3\text{SbO}_7$  ceramics sintered at different temperatures are shown in Fig. 3. It is seen that dense microstructure can be observed for  $\text{Bi}_3\text{SbO}_7$  ceramics sintered in the temperature range 960–1000 °C with almost no pores. In this temperature range, the  $\text{Bi}_3\text{SbO}_7$  ceramics are composites of both  $\alpha$  and  $\beta$  phases. Unfortunately, although it seems that there are more than one kind of shape for the grains, the different grains cannot be separated from the back scattering electron images due to the same composition. It is clear that the grain size increases with the sintering temperature.

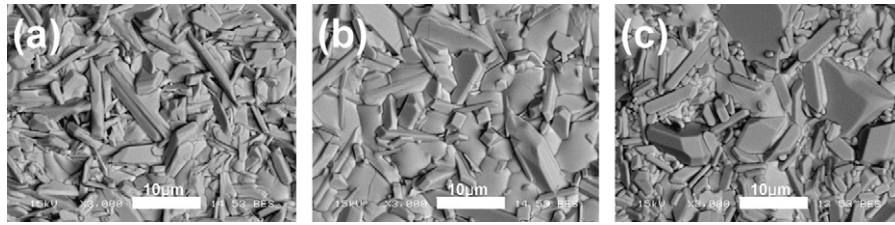


Fig. 3. BEI of  $\text{Bi}_3\text{SbO}_7$  ceramics sintered at 960 °C/2 h (a), 980 °C/2 h (b) and 1000 °C/2 h (c).

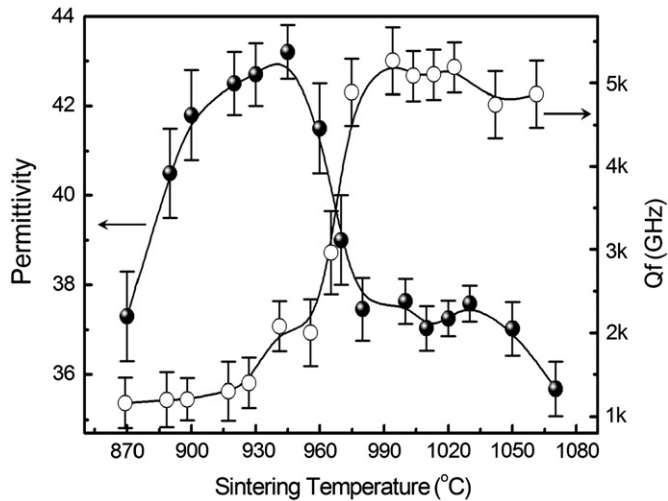


Fig. 4. Microwave permittivity and  $Qf$  values of  $\text{Bi}_3\text{SbO}_7$  ceramics as a function of sintering temperature (several samples prepared by different starting  $\text{Sb}_2\text{O}_3$  and sintered at the same temperature were measured to calculate the error bar).

Table 1

Comparison of microwave dielectric properties of  $\text{Bi}_3\text{SbO}_7$  ceramics reported in this work and Manier et al.'s work.

| Phase composition                | Resonant frequency (GHz) | Dielectric permittivity | Q value | $Qf$ value (GHz) | TCF (ppm/°C) | Reference |
|----------------------------------|--------------------------|-------------------------|---------|------------------|--------------|-----------|
| –                                | 6.6457                   | 42.1                    | 1426    | 9480             | –31.3        | [21]      |
| –                                | 6.618                    | 41.6                    | 1426    | 9440             | –32          | [21]      |
| $\alpha\text{-Bi}_3\text{SbO}_7$ | 5.625                    | 43.2                    | 370     | 2078             | 0            | This work |
| $\beta\text{-Bi}_3\text{SbO}_7$  | 5.914                    | 37.6                    | 860     | 5080             | –120         | This work |

Microwave dielectric properties of  $\text{Bi}_3\text{SbO}_7$  ceramics as a function of sintering temperature are shown in Fig. 4. Resonant frequency lied between 5.6 and 6.4 GHz. Microwave permittivity first reached saturated value about 43.2 at 945 °C and at this temperature only pure  $\alpha\text{-Bi}_3\text{SbO}_7$  was revealed from XRD analysis.  $Qf$  value of  $\alpha\text{-Bi}_3\text{SbO}_7$  ceramic was about 2080 GHz. After  $\alpha\text{-Bi}_3\text{SbO}_7$  transformed to  $\beta\text{-Bi}_3\text{SbO}_7$ , permittivity decreased to about 37.6 and  $Qf$  values increased to about 5080 GHz for ceramics sintered around 1020 °C. To the best of our knowledge, this is the first time to distinguish the microwave dielectric properties of  $\alpha\text{-Bi}_3\text{SbO}_7$  and  $\beta\text{-Bi}_3\text{SbO}_7$ . Permittivity reported here had the similar value to that reported by Manier et al. [21] but the  $Qf$  values were a little smaller than their results (dielectric loss between  $5 \times 10^{-4}$  and  $7 \times 10^{-4}$ , resonant frequency between 6.6 and 7.3 GHz) as shown in Table 1. Temperature coefficients of resonant frequency TCF of  $\text{Bi}_3\text{SbO}_7$  ceramics as a function of sintering temperature are shown in Fig. 5. When sintering temperature was lower than 960 °C, TCF values of  $\alpha\text{-Bi}_3\text{SbO}_7$  were shifting between +4 and –22 ppm/°C and the absolute

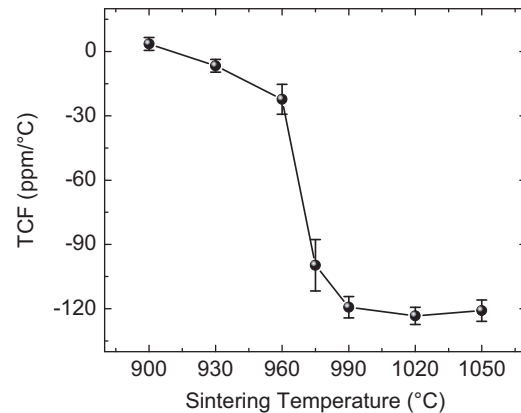


Fig. 5. Temperature coefficient of resonant frequency (TCF) of  $\text{Bi}_3\text{SbO}_7$  ceramics as a function of sintering temperature.

values were not very large. When sintering temperature was above 960 °C,  $\beta\text{-Bi}_3\text{SbO}_7$  occurred and TCF values sharply decreased to near –120 ppm/°C and became stable as temperature increased further.

#### 4. Conclusions

Low temperature phase  $\alpha\text{-Bi}_3\text{SbO}_7$  could be formed at about 890 °C. It gradually transformed to the high temperature phase  $\beta\text{-Bi}_3\text{SbO}_7$  when temperature was above 960 °C and pure  $\beta\text{-Bi}_3\text{SbO}_7$  could be obtained at around 1020 °C. Microwave dielectric constants of  $\alpha\text{-Bi}_3\text{SbO}_7$  ceramic and  $\beta\text{-Bi}_3\text{SbO}_7$  ceramic were 43.2 and 37.6,  $Qf$  values were 2078 and 5080 GHz, respectively. TCF of  $\alpha\text{-Bi}_3\text{SbO}_7$  ceramic was near zero and TCF of  $\beta\text{-Bi}_3\text{SbO}_7$  ceramic was about –120 ppm/°C. The  $\text{Bi}_3\text{SbO}_7$  ceramic might be a candidate for LTCC technology.

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